

<b>Notice of References Cited</b>		Application/Control No. 10/645,868	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner CHRISTOPHER R. LAMB	Art Unit 2627	Page 1 of 1

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*	A	US-2002/0031069	03-2002	Nakane et al.	369/53.15
*	B	US-6,714,493	03-2004	Kishimoto et al.	369/44.38
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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